

# 2SC3312

## Silicon NPN epitaxial planar type

For low-frequency and low-noise amplification

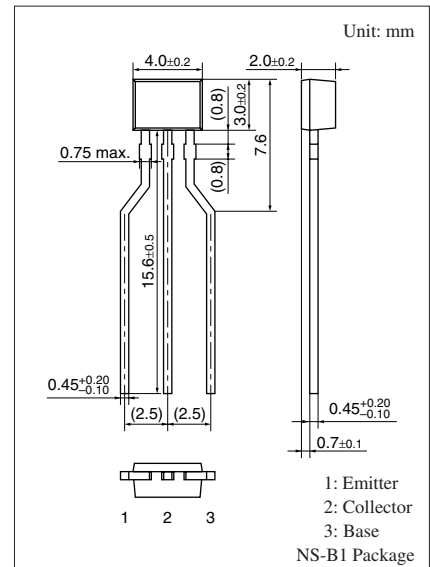
Complementary to 2SA1310

### ■ Features

- Optimum for high-density mounting
- Allowing supply with the radial taping
- Low noise voltage NV

### ■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

Parameter	Symbol	Rating	Unit
Collector-base voltage (Emitter open)	$V_{\text{CBO}}$	60	V
Collector-emitter voltage (Base open)	$V_{\text{CEO}}$	55	V
Emitter-base voltage (Collector open)	$V_{\text{EBO}}$	7	V
Collector current	$I_{\text{C}}$	100	mA
Peak collector current	$I_{\text{CP}}$	200	mA
Collector power dissipation	$P_{\text{C}}$	300	mW
Junction temperature	$T_{\text{j}}$	150	$^\circ\text{C}$
Storage temperature	$T_{\text{stg}}$	-55 to +150	$^\circ\text{C}$



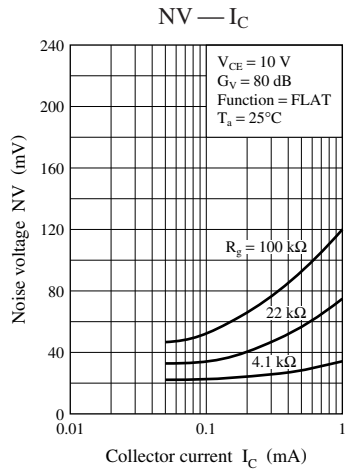
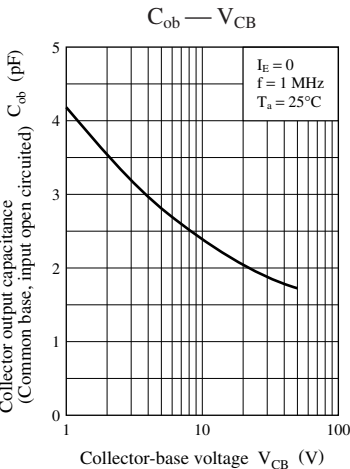
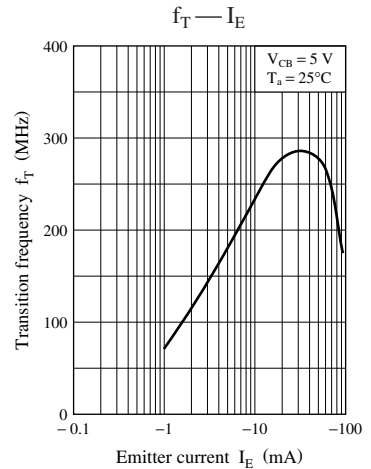
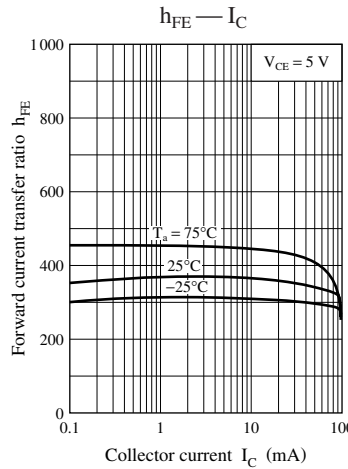
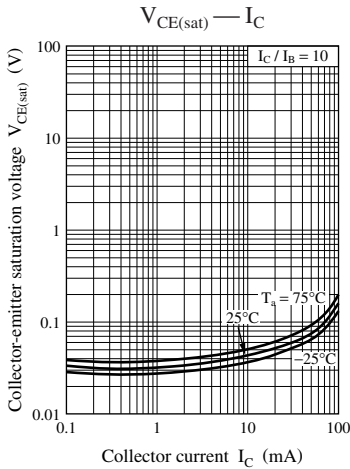
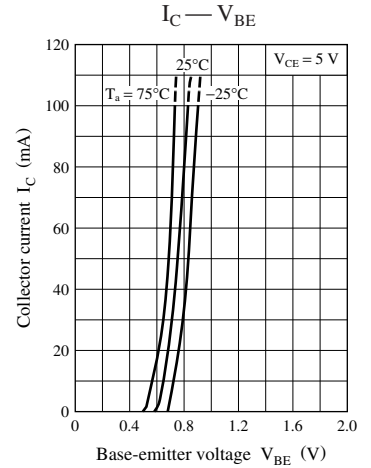
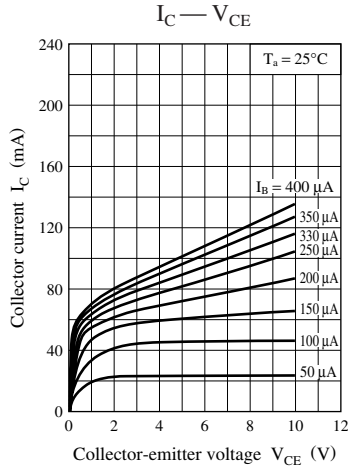
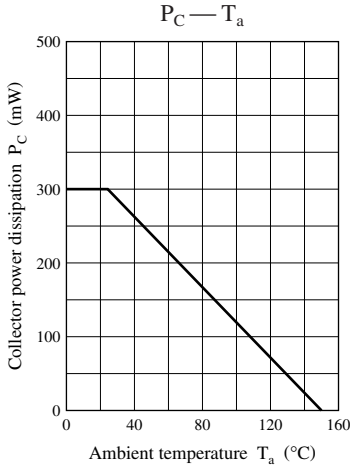
### ■ Electrical Characteristics $T_a = 25^\circ\text{C} \pm 3^\circ\text{C}$

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Collector-base voltage (Emitter open)	$V_{\text{CBO}}$	$I_{\text{C}} = 10 \mu\text{A}$ , $I_{\text{E}} = 0$	60			V
Collector-emitter voltage (Base open)	$V_{\text{CEO}}$	$I_{\text{C}} = 2 \text{ mA}$ , $I_{\text{B}} = 0$	55			V
Emitter-base voltage (Collector open)	$V_{\text{EBO}}$	$I_{\text{E}} = 10 \mu\text{A}$ , $I_{\text{C}} = 0$	7			V
Base-emitter voltage	$V_{\text{BE}}$	$V_{\text{CE}} = 1 \text{ V}$ , $I_{\text{C}} = 30 \text{ mA}$			1	V
Collector-base cutoff current (Emitter open)	$I_{\text{CBO}}$	$V_{\text{CB}} = 20 \text{ V}$ , $I_{\text{E}} = 0$			0.1	$\mu\text{A}$
Collector-emitter cutoff current (Base open)	$I_{\text{CEO}}$	$V_{\text{CE}} = 20 \text{ V}$ , $I_{\text{B}} = 0$			1	$\mu\text{A}$
Forward current transfer ratio *	$h_{\text{FE}}$	$V_{\text{CE}} = 5 \text{ V}$ , $I_{\text{C}} = 2 \text{ mA}$	180		700	—
Collector-emitter saturation voltage	$V_{\text{CE(sat)}}$	$I_{\text{C}} = 100 \text{ mA}$ , $I_{\text{B}} = 10 \text{ mA}$			1	V
Transition frequency	$f_{\text{T}}$	$V_{\text{CB}} = 5 \text{ V}$ , $I_{\text{E}} = -2 \text{ mA}$ , $f = 200 \text{ MHz}$		200		MHz
Noise voltage	NV	$V_{\text{CE}} = 10 \text{ V}$ , $I_{\text{C}} = 1 \text{ mA}$ , $G_{\text{V}} = 80 \text{ dB}$ $R_{\text{g}} = 100 \text{ k}\Omega$ , Function = FLAT			150	mV

Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

2. \*: Rank classification

Rank	R	S	T
$h_{\text{FE}}$	180 to 360	260 to 520	360 to 700



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